Search Notes		
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Application/Control No.	Applicant(s)/Patent under Reexamination	
10/626,864	SHI ET AL.	
Examiner	Art Unit	
Naum R. Levin	2825	

SEARCHED			
Class	Subclass	Date	Examiner
716	4	6/2/2006	ΝL
716	19-21	6/2/2006	NL
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INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner
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	xt search - interference printout	6/2/2006	NL

SEARCH NOT (INCLUDING SEARCH	'ES Strategy	)
	DATE	EXMR
EAST (US-PGPUB, USPAT, EPO, JPO, DERWENT)- See search histoty printouts	6/2/2006	NL